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## Time-resolved pump-probe experiment at PO4 with synchrotron and laser

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We combined narrow-bandwidth soft X-ray radiation, with an optical femtosecond laser (515nm, 2.4eV), to study the Auger cascade of core-excited atomic Ne in a time-resolved fashion. An X-ray pulse of 100ps duration and energy near 867eV stimulates the Ne1s->3p excitation. This core-excited state decays within its lifetime of ~2.4fs, almost instantaneous for every synchrotron and for most existing light sources. Most of the Ne1s-13p decays occur via emission of a fast Auger electron into a Ne+ ion, predominantly with 2 valence vacancies and one electron occupying a higher-lying valence orbital. These Ne+ products can undergo further Auger decay, emitting a "2nd-step" Auger electron in the energy range up to ~35eV.

Unlike the almost instantaneous Auger decay of the core-excited state, the 2nd-step decay can occur on a very broad time-range spanning up to several ns. During this time interval we fire a laser pulse into the interaction region probed by the X-ray, and we monitor the Auger electron spectra for the 2nd step decay while scanning the laser delay. If the laser precedes the X-ray it has no influence on the spectra, because Ne cannot be energetically accessed. If the laser arrives too long after the X-ray it also has no influence because all the Ne+ produced by the Auger cascade have already decayed further. But if the laser delay is comparable with the Ne+ lifetimes, in the ns regime, the laser pulse can alter the population distribution of the various Ne+ states, which is naturally mapped into a change of the 2nd-step Auger spectra.

We monitor the Auger electron spectra and control the relative delay between the X-ray and laser pulses as well as laser wavelength and intensity. From these delay-resolved Auger spectra we can extract dynamic information concerning the Ne+ involved in the cascade. Lifetimes are extracted and compared with theoretical calculations.

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